

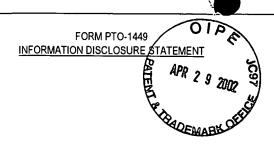


FORM PTO-1449						
INFORMATION DISCLOSURE STATEMENT						

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ATTY. DOCKET NO.: 1671-0099	SERIAL NO.: To be assigned
APPLICANT(s): Lester et al.	1888 1888
FILING DATE: Herewith	GROUP ART UNIT: To be assigned

			U:	S. PATENT DOCUMENTS	<u> </u>		
		DOCUMENT NUMBER		NAME	CLASS	SUB-CLASS	FILING DATE
NDI	AA	4,695,282	09/22/1987	Forte et al.			
KK	AB	4,704,127	11/03/1987	Averill et al.	<u> </u>		
KRL							
Kei	AC	5,935,174	08/10/1999	Dye			
KPL	AD	5,938,702	08/17/1999	Lopez et al.			·
KPL KPL KPL KPL	AE	5,972,032	10/26/1999	Lopez et al.	1		
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
	AL						Yes No
	AM						Yes No
	AN						Yes No
	AO		,				Yes No
	AP						Yes No
7			OTHER (Including	Author, Title, Date, Pertinent Pages, etc.)	700_000		
	AQ	1					
	AR	1					
	AS	1					
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



ATTY. DOCKET NO. 1671-0099	APPLICATION NO. 09/678,032				
APPLICANT: Lester et al.					
FILING DATE: October 3, 2000	GROUP 3738				
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				U.S.	PATENT DOCUMENTS			
EXAMINER INITIAL			CUMENT MBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
KPL	AA	5,0	30,402	07/09/1991	Zachariades			
KPL	AB	6,0	17,975	01/25/2000	Saum et al.			
Kar	AC	6,24	45,276	06/12/2001	McNulty et al.			
	AD						TECHWOLOGY	
	AE						P S	X D
	AF						9	3 0
	AG						CENTER	1 200
	AH						N. N	2002
	AI						R ₂	2 11
	AJ						R3700	
	AK							
				FOREIG	GN PATENT DOCUMEN	TS		
EXAMINER INITIAL			CUMENT MBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
KRL	AL	EP	0722973	07/24/1996	Europe			Yes No
KPL	AM	EP (0729981	09/04/1996	Europe			Yes No
KPL	AN	WO	99/52474	10/21/1999	PCT			Yes No
	AO							Yes No
	AP							Yes No
			OTI	HER (Including A	Author, Title, Date, Pertin	ient Pages, etc.)	<u> </u>	L
KPL	AQ	1	Dijkstra, D. beam irradia	J. et al., "Cross-lin ation", Polymer, Jo	king of ultra-high molecula rdan Hill, Oxford, Great B	ar weight polyethylene ritain, vol. 30, no. 5, N	in the melt by m lay 1, 1989, pag	eans of electron es 866-873.
	AR	1						
	AS	1						
EXAMINER Kunv	rin		and			09/	ONSIDERED	-
EXAMINER : conformance and	Initial if r d not con:	eferenc sidered.	e considered, Include copy	whether or not cita of this form with	tion is in conformance with next communication to App	h MPEP 609. Draw lin olicant.	ne through citation	on if not in